

**Notice of References Cited**

Application/Control No.

10/573,471

Applicant(s)/Patent Under  
Reexamination  
TAKENAKA ET AL.

Examiner

MCDIEUNEL MARC

Art Unit

3664

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,243,623	06-2001	Takenaka et al.	700/245
*	B	US-5,455,497	10-1995	Hirose et al.	318/568.12
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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